Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
09/522,178	INOUE ET AL.	
Examiner	Art Unit	
Lun-See Lao	2644	

SEARCHED					
					
Class	Subclass	Date	Examiner		
381	71.7-714	8/5/05	Lrs.		
	56-57				
	103				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
		DATE	EXMR		
EAST		8/05/05	۷٠\$		